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To be published in: CONF-961202--10

Microstructure Evolution During Irradiation

Edited by T. Diaz de la Rubia, G. S. Was, I. M. Robertson, and L. W. Hobbs
Materials Research Society Symposium Proceedings, 1997

Electron-Irradiation-Induced Crystallization of Amorphous Orthophosphates

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December 1996

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LOCKHEED MARTIN ENERGY RESEARCH CORP.
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ELECTRON-IRRADIATION-INDUCED CRYSTALLIZATION OF AMORPHOUS ORTHOPHOSPHATES

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ABSTRACT

Amorphous LaPO₄, EuPO₄, GdPO₄, ScPO₄, LuPO₄, and fluorapatite [Ca₅(PO₄)₃F] were irradiated by the electron beam in a transmission electron microscope. Irradiations were performed over a range of temperatures from -150 to 300 °C, electron energies from 80 to 200 keV, and current densities from 0.3 to 16 A/cm². In all cases, the materials crystallized to form a randomly oriented polycrystalline assemblage. Crystallization is driven dominantly by inelastic processes, although ballistic collisions with the target nuclei can become important at energies higher than 175 keV, particularly in apatite. Using a high current density, crystallization is so fast that continuous lines of crystallites can be "drawn" on the amorphous matrix.

INTRODUCTION

In this study, we examine in detail the effects of 80 to 200 keV electron irradiation on several amorphous orthophosphates of the composition APO₄ (A = Sc, La, Eu, Gd, or Lu) and fluorapatite. The orthophosphates were chosen for this study for several reasons. First, in an earlier work [1], we noted that the critical amorphization dose for heavy ions in natural monazite [(La,Ce,Th)PO₄] was significantly higher in the presence of the electron beam in the TEM, suggesting that these compounds would be good candidate materials for a study of electron-irradiation-induced crystallization effects. Next, the effect of electron irradiation in the orthophosphates is considered important for a variety of technological reasons, including: a) the orthophosphates are suggested host phases for high level nuclear waste [2,3], in which a detailed understanding of radiation effects is clearly needed, b) natural orthophosphates are used extensively in uranium-lead (monazite) and uranium fission track (fluorapatite) dating, in which the age of portions of the earth's crust may be determined (e.g., [4,5]), and c) our initial work has shown that these materials may be good candidates for electron or laser lithography. Of the materials investigated here, LaPO₄, EuPO₄, and GdPO₄ are isostructural, having the *P2₁/n*, Z = 4 (monazite) structure, as are ScPO₄ and LuPO₄, which have the closely related *I4₁/amd*, Z = 4 (zircon) structure. Apatite has an unrelated structure, but is similar in that it consists of a network of isolated PO₄ tetrahedra interconnected through metal-cation polyhedra.

EXPERIMENTAL

Synthetic crystals of LaPO₄, EuPO₄, GdPO₄, ScPO₄, and LuPO₄ were grown using the flux technique [3]. M₂O₃ (M = Ln, Sc) was combined with lead hydrogen phosphate and heated to 1360 °C in a platinum crucible. The system was held at this temperature for several days, cooled at 1 °C per hour to 900 °C, and then quenched to room temperature. Single crystals of the orthophosphate were removed from the Pb₂P₂O₇ flux by boiling in nitric acid for four weeks. Sample composition was subsequently checked by EDS, and X-ray diffraction analysis confirmed the monazite and zircon structure-types.

A natural single crystal of fluorapatite from Ontario, Canada was used in this study. Polished specimens were analyzed on a JEOL 733 electron microprobe operated at an accelerating voltage of 15 keV, and the beam current was 20 nA. The beam diameter was approximately 1 μm . All elements were determined by wavelength-dispersive spectrometry (WDS). Data were reduced by the ZAF-4 correction technique using Oxford GENIE microprobe automation and data analysis software.

Samples were ion-milled to perforation using 4 keV Ar ions and irradiated in the IVEM Facility at Argonne National Laboratory, which consists of a Hitachi H9000NAR electron microscope interfaced to a 400 keV ion accelerator. Samples were irradiated by 800 keV Kr^{2+} ions at room temperature to a dose double that required for amorphization, based on the absence of electron diffraction maxima.

The samples were subsequently irradiated by an electron beam in a JEOL 2000FX or JEOL 2010 transmission electron microscope. The JEOL 2000FX is equipped with Gatan heating and cooling stages, each of which has a Faraday cup. All non-room-temperature experiments and all dose measurements were done on this microscope. The dose was obtained by measuring the current in the Faraday cup before and after each irradiation, and by dividing this value by the beam area. The beam area was obtained by taking a series of unobstructed photographs of the electron beam and digitally analyzing the exposed intensity. High-resolution imaging was done on the JEOL 2010, equipped with a slow scan camera. Crystallization was monitored by examining selected-area electron diffraction patterns and the corresponding bright and dark field images. The effects of electron energy were investigated by varying the accelerating voltage from 80 to 200 keV.

RESULTS AND DISCUSSION

Electron microprobe analysis of the natural apatite single crystal showed that it is a pure endmember fluorapatite, having an average chemical composition of $\text{Ca}_{4.99}\text{P}_{2.95}\text{O}_{12}\text{F}_{1.05}$. Minor amounts of Sr, Na, and Si were detected, and make up the charge balance. Chemical zoning was not observed. EDS analysis of the synthetic orthophosphate crystals did not reveal any impurities. Subsequent to ion-irradiation, all the materials were checked by EDS in the TEM to account for possible ion-irradiation-induced chemical changes. For the synthetic orthophosphates, the EDS spectra before and after ion-irradiation were indistinguishable. In apatite, some fluorine + oxygen loss is evident (the fluorine and oxygen peaks suffer severe overlap). Implanted Kr was not detected in the EDS spectra, consistent with TRIM-96 results which indicate less than 1% implantation.

Using 200 keV electrons at room temperature and a beam current of 1.45 A/cm², amorphous LaPO_4 and GdPO_4 crystallized to form a randomly oriented polycrystalline assemblage after a dose of 6.78×10^{20} and 7.70×10^{20} cm⁻², respectively. The dose for EuPO_4 was indistinguishable from GdPO_4 , within experimental error. The first crystalline nuclei were observed after less than 60 seconds under these conditions. These nuclei grew with increasing irradiation at the same time as further nuclei formed in the still-amorphous regions. For LaPO_4 and GdPO_4 , the result was a randomly oriented polycrystalline assemblage of crystallites having an average diameter of approximately 100 nm (Fig. 1).

Electron-irradiation-induced crystallization in ScPO_4 and LuPO_4 required an approximately 10x higher dose than for the monazite-structure materials. Under identical conditions as described above, ScPO_4 required a dose of 9.11×10^{21} and LuPO_4 a dose of 1.38×10^{22} cm⁻² to completely crystallize. The crystallites were somewhat larger in this case, with an average diameter of 150 nm. For all the materials investigated except fluorapatite, increasing the

current density by focusing the second condenser lens increased the crystallization time, so that letters could be continuously drawn on the amorphous matrix with a size apparently only dependent on the diameter of the electron beam (Fig. 2). Overall, the crystallization dose using 200 keV electron irradiation increased in the order LaPO_4 , GdPO_4 , apatite, ScPO_4 , LuPO_4 .

The microstructural development of amorphous fluorapatite under electron irradiation is significantly different than for the lanthanide orthophosphates. Using 200 keV electrons ($J = 1.6 \text{ A/cm}^2$), extensive bubble formation was observed. The bubbles grew up to 200 nm in diameter and tended to coagulate at the edge of the electron beam. The first crystalline nuclei were observed after approximately 2 minutes of irradiation. These nuclei grew epitaxially with continued irradiation, but the nucleation process slowed down and eventually stopped altogether, resulting in a few very large (up to 2 μm diameter) randomly oriented crystallites (Fig. 3). Single-crystal selected-area electron diffraction patterns from these crystallites unambiguously confirmed the apatite structure. In some cases, amorphous material could be identified along the grain boundaries and in the interstices between crystallites: this material did not crystallize even after prolonged irradiation. Irradiations were repeated using a beam current of 16 A/cm^2 , initially to determine the effect of dose rate (or beam heating) on the crystallization of apatite. However, under these conditions, apatite did not crystallize; instead, cubic CaO precipitated out of the amorphous matrix. Extensive bubble formation occurred, as documented above under low beam current conditions. Even after prolonged irradiation, apatite could not be induced to crystallize under these conditions.

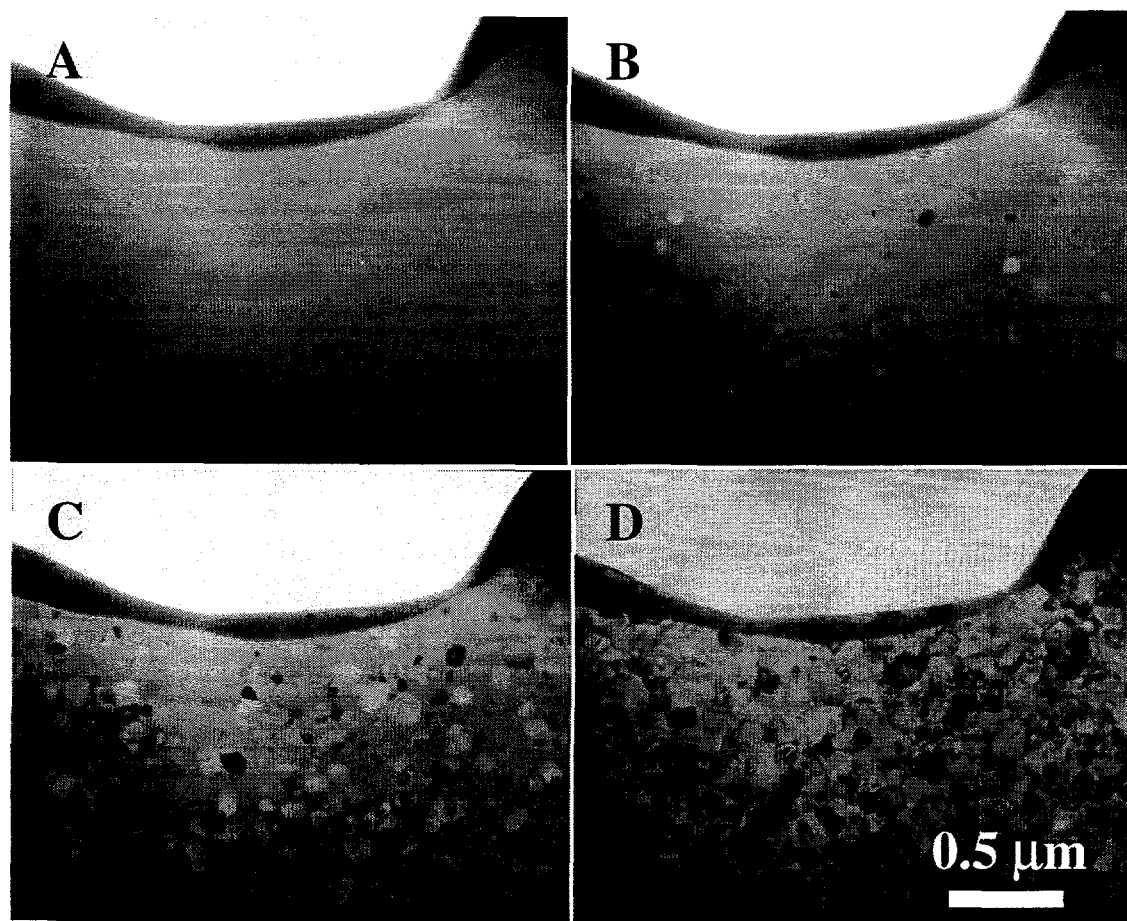


Fig. 1. Bright-field images showing an electron-beam-induced crystallization sequence in LaPO_4 , using a beam current density of 0.3 A/cm^2 : Unirradiated (A), 1.5 minutes (B), 4 minutes (C), 6 minutes (D).

Electron irradiations were performed over the range of -150 to 300 °C, using 200 keV electrons. In all cases, the crystallization dose decreased as temperature increased. For the APO_4 orthophosphates, no change in the morphology of the crystallites as a function of temperature was observed. The incubation time for the appearance of crystalline nuclei decreased at a similar rate as the overall crystallization time. However, in apatite, electron irradiation at 16 A/cm^2 at 300 °C could not induce the precipitation of CaO, in contrast to the room temperature experiments. Instead, the material crystallized to randomly oriented small (~75 nm average diameter) apatite crystallites (Fig. 3). Significantly less bubble formation was observed, and no remaining amorphous material was detected. Thus, in fluorapatite, the effect of temperature is to change the phase assemblage crystallized as a result of electron irradiation.

Irradiations were carried out using electron energies ranging from 80 to 200 keV at room temperature. For all the orthophosphates, the lowest electron dose for crystallization was for the 80 keV electrons, the lowest energy used. For the monazite- and zircon-structure

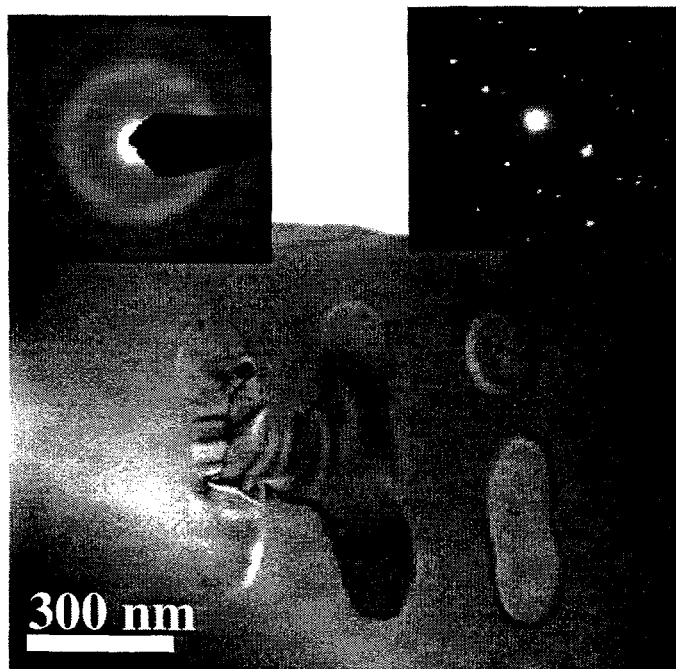


Fig. 2. Electron-irradiation-induced crystallization in EuPO_4 , with corresponding diffraction patterns from the amorphous matrix (top left), and from the center of the "H" (top right).

orthophosphates, the crystallization dose increased with increasing accelerating voltage (Fig. 4). This increase is directly proportional to the decrease in dE/dx calculated from the Bethe equation. In the case of fluorapatite, the situation is different: the crystallization dose reaches a maximum at approximately 175 keV and decreases again at 200 keV.

Any investigation of electron irradiation effects requires some discussion of the possibility that the observed microstructure evolution is due to electron beam heating, not ionization or nuclear collisions. There is no direct way of measuring sample heating from the electron beam, but Fisher's model [6] for calculating this parameter has been widely applied. According to this model, the temperature rise varies from 5 to 40 °C in these experiments. These values are considered a maximum because a) the highest measured value for the beam current was used in each case, b) the lowest available thermal conductivities for phosphate glass was used in these calculations. Additionally, the assertion that the electron beam-induced temperature rise drives the observed phase transformations is inconsistent with the results for fluorapatite. If temperature drives the crystallization, for example, of CaO (focused beam conditions), then CaO should crystallize in the high temperature experiments (not observed).

Another possibility, other than nucleation and growth, is that electron irradiation may induce epitaxial recrystallization of relict crystallites that may be present but undetectable in the amorphous matrix after ion irradiation. For example, Miller and Ewing [7] showed that as much as 20% crystalline material in the path of the electron beam may be "invisible" in the electron microscope. However, we discard this hypothesis for the following reasons:

orthophosphates, the crystallization dose increased with increasing accelerating voltage (Fig. 4). This increase is directly proportional to the decrease in dE/dx calculated from the Bethe equation. In the case of fluorapatite, the situation is different: the crystallization dose reaches a maximum at approximately 175 keV and decreases again at 200 keV.

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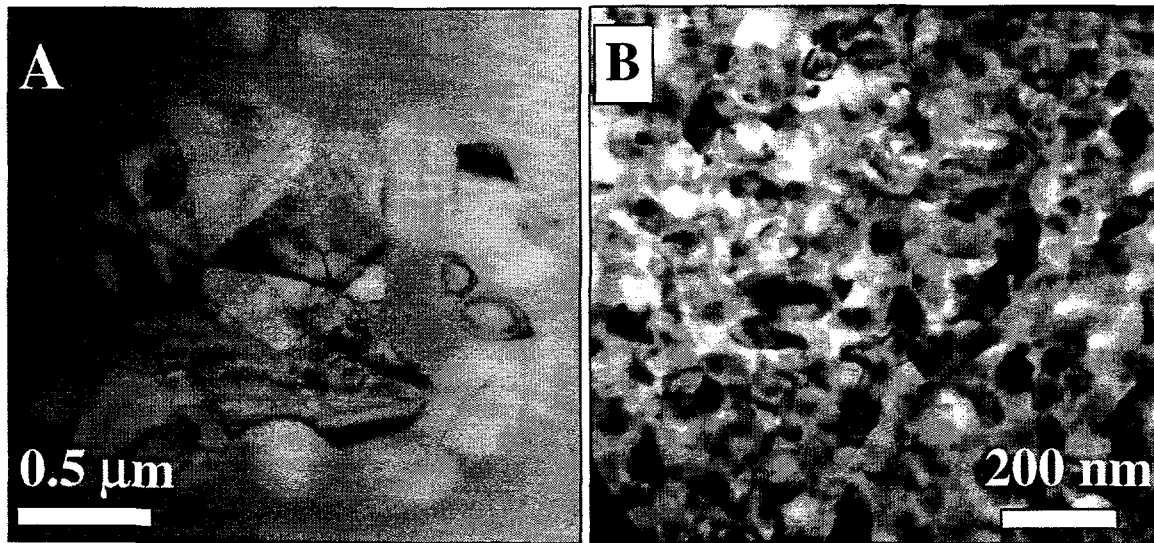


Fig. 3. Electron-irradiation-induced crystallization in fluorapatite at room temperature (A) and at 300 °C (B), using a beam current density of 1.63 A/cm². Irradiation at room temperature gives a complex assemblage of randomly oriented coarse-grained apatite crystallites, gas bubbles, and a remaining amorphous component along the grain boundaries. Irradiation at 300 °C (B) gives a relatively fine-grained assemblage of apatite crystallites, with only a few small gas bubbles at the grain boundaries and no observable amorphous component.

1. The materials were irradiated to a dose double that required for amorphization based on the absence of electron diffraction maxima. If 20% of the material was actually still crystalline, doubling the dose should be sufficient to amorphize the entire thickness.
2. The resulting phase assemblage is randomly oriented. Ion irradiation of single crystals can lead to the development of slightly rotated crystallite islands in an amorphous matrix; however, this rotation is invariably small.
3. The precipitation of CaO from amorphous apatite is not consistent with the presence of relict apatite crystals

The crystallization mechanism could be a result of defect mobility as a result of ballistic collisions with the target nuclei, bond breaking and reorganization due to ionization processes, beam heating, or a combination of these. The increase in dose with increasing beam energy documented for these materials and the strong correlation with the electronic stopping power calculated from the Bethe equation ($r > 0.95$ in all cases except apatite at energies greater than 175 keV) strongly suggest that the crystallization

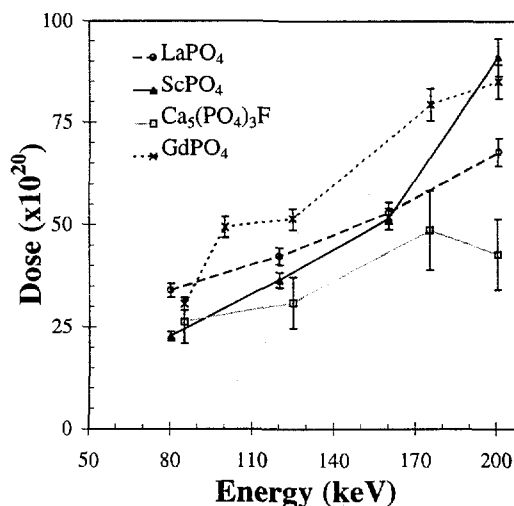


Fig. 4. Crystallization dose as a function of electron energy in the orthophosphates (only LaPO₄, GdPO₄, ScPO₄, and apatite are shown, for clarity). The doses for LaPO₄ and GdPO₄ are multiplied by 10 to plot on the same axis. In all cases, the crystallization dose increases as a function of electron energy, except for the 175 - 200 keV region for apatite.

mechanism is driven dominantly by ionization processes. At high energies ballistic collisions may enhance the crystallization process, as suggested by the results for fluorapatite, in which the crystallization dose decreases above 175 keV.

The ease of crystallization in these materials is dependent on both structure and chemistry. Within the APO_4 group, the monazite structure-type materials crystallized more readily than the zircon structure-type materials. Increasing the atomic number of the A-site cation had the effect of increasing the crystallization dose within each structure-type. Monazite structure-type materials have previously been shown to have a low E_a for annealing under ion-irradiation [1], attributed in part to the lower symmetry requirements, as compared with the higher symmetry zircon structure-type. These results are consistent with that view.

These results have potential application in electron lithography, as demonstrated by Fig. 2. Of all the materials investigated, amorphous LaPO_4 is the most sensitive to electron irradiation. Crystallization in this material was so fast, even for a low current density, that "controlled" crystallization in the TEM was not possible. However, in the other orthophosphates the crystallization was slow enough that a focused electron beam could be used to continuously "draw" lines of crystallites by using the beam shift control knobs. Our experiments show that the size of the regions crystallized is dependent only on the diameter of the electron beam. Thus, we anticipate that nanometer-scale crystalline zones could easily be produced using a finer electron beam.

CONCLUSION

We have shown that a low energy (80 - 200 keV) electron beam can be used to crystallize some ion-beam-amorphized insulating ceramics by a predominantly ionization-driven nucleation and growth process. The nucleated phase may be the same as the original unirradiated phase, as in the APO_4 group, or it may be different, as in fluorapatite. The crystallization dose generally increases with increasing electron energy. Heating effects from the electron beam are not important. The rate of electron-beam-induced crystallization corresponds to the irradiation-enhanced annealing activation energies and critical amorphization temperatures observed during ion-irradiation of these materials.

ACKNOWLEDGMENTS

The authors thank the staff at the HVEM-Tandem Facility at Argonne National Laboratory for their assistance with the ion irradiations. This work was supported by BES/DOE (grant # DE-FG03-93ER45498). A.M. acknowledges financial support through a scholarship from FCAR (Québec), and from the Mineralogical Society of America.

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